

## Test Report

# CITIZEN SOLAR PRIVATE LIMITED

REPORT NUMBER: 4791205189-OTHER-S1

PROJECT NUMBER: 4791205189

| <u>Select the applicable t</u> | test |
|--------------------------------|------|
| • •                            |      |
| locations:                     |      |

## □LOCATION 1:

UL India Private Limited, Laboratory building, Kalyani Platina Campus, Sy.no.129/4, EPIP Zone, Phase II, Whitefield, Bangalore – 560 066

## $\square$ LOCATION 2:

P:91-80-41384400

UL India Private Limited,
Oak building, Kalyani Platina
Campus, Sy.No.129/4,
EPIP Zone, Phase II, Whitefield,
Bangalore, Karnataka – 560 066

## $\square$ LOCATION 3:

UL India Private Limited, 30/A, I Stage, Vishveshwarya Industrial Estate, Doddanekkundi Industrial Area, Bangalore - 560048

## $\boxtimes$ Other:

(#Refer Page no. for Test lab location)

Form-ULID-003263 (DCS:12-LO-F0852) Issue: 19.1 Page **1** of **25** 



TEST DISCIPLINE: ELECTRONICS PRODUCT GROUP: SOLAR PANEL

#### **General details**

|                                     | I au   |                       |                          |  |  |  |
|-------------------------------------|--|-----------------------|--------------------------|--|--|--|
|                                     | Citizen Solar Private Limited  |                       |                          |  |  |  |
| Customer / Applicant                | Mehsana, Gujarat-382715  |                       |                          |  |  |  |
|                                     |  |                       |                          |  |  |  |
|                                     | Citizen Solar Private Limited  |                       |                          |  |  |  |
| Manufacturer                        | New Survey No.966, Villag  | e: Indrad, Chhatral K | adi Road, Ta.Kadi, Dist. |  |  |  |
|                                     | Mehsana, Gujarat-382715  |                       |                          |  |  |  |
| Program                             | OTHER  |                       |                          |  |  |  |
| Item Under Test                     | Mono-crystalline Photovolta  | aic module            |                          |  |  |  |
| Model                               | Representative sample of Model: CSPL-144MHC-TF-545                                   |                       |                          |  |  |  |
| Number of Samples                   | 03   |                       |                          |  |  |  |
| UL. Sample Identification           | Refer Page no.6  Refer Summary of Test results for multiple samples                  |                       |                          |  |  |  |
| Manufacturer Serial Number (if any) | Refer Page no.6  |                       |                          |  |  |  |
| Condition of IUT on receipt         | Good   |                       |                          |  |  |  |
| Date of Receipt                     | 25 □pril 2024  |                       |                          |  |  |  |
| Applicable Standard                 | IEC 62716 Edition 1.0, 2013-06- Photovoltaic □PV□ modules □mmonia corrosion testing. |                       |                          |  |  |  |
| Date of Testing (Start date)        | 18 □une 2024   | End Date              | 16 □uly 2024             |  |  |  |
| UL general ambient                  | Temperature in □C  |                       | □23 □5C□                 |  |  |  |
| condition                           | Relati□ehumidity in □  |                       | □70 □                    |  |  |  |
| Date of Issue                       | 26 □uly 2024   |                       |                          |  |  |  |
| Test In⊡charge                      | Fu□iang tiao   |                       |                          |  |  |  |
|                                     |  |                       |                          |  |  |  |

| M. □ayda□shmi                 | N. Srimathy             |
|-------------------------------|-------------------------|
| Engineering Project □ssociate | Senior Project Engineer |
| Re□ie□ed by                   | Authori□edsignatory     |

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CIN: U74200KA1997PTC023189

Page 2 of 25



#### General Remarks (If any)

#Test lab location (Other than UL India Private Limited)

| Test Laboratory/Location |  |
|--------------------------|--|
| [X] UL or Affiliate      | [X] Subcontract Lab  |
| Company Name             | China Telecommunication Technology Labs  |
| Location                 | CuiHu Cloud Center,No. 1 Gaolizhang Road,Wenquan Town, Haidian District, Beijing |

Test witnessed by: Jason You (Senior Project Engineer, UL China)

**Description of Item under Test (IUT)** 

Mono Crystalline modules. A total of 2 samples were tested. 1 sample was a control sample.

#### Series model covered under this report:

Below listed models covered in this test report, on basis of having same construction, design and BOM as declared by manufacturer. No testing was considered necessary to cover the listed models below. The only changes are the electrical ratings, number of cells and overall dimension from the tested model.

|                | Models Covered Under this report:                           |
|----------------|---|
|                | With Transparent Backsheet:                                 |
|                | 144 Half Cut Cell Series (182mm)                            |
|                | CSPL-144MHC-TF-560, CSPL-144MHC-TF-555, CSPL-144MHC-TF-550, |
|                | CSPL-144MHC-TF-545, CSPL-144MHC-TF-540, CSPL-144MHC-TF-535, |
|                | CSPL-144MHC-TF-530, CSPL-144MHC-TF-525, CSPL-144MHC-TF-520  |
|                | 132 Half Cut Cell Series(182mm)                             |
| Models covered | CSPL-132MHC-TF-495, CSPL-132MHC-TF-490, CSPL-132MHC-TF-485, |
|                | CSPL-132MHC-TF-480  |
|                | 120 Half Cut Cell Series(182mm)                             |
|                | CSPL-120MHC-TF-450, CSPL-120MHC-TF-445, CSPL-120MHC-TF-440, |
|                | CSPL-120MHC-TF-435  |
|                | 108 Half Cut Cell Series (182mm)                            |
|                | CSPL-108MHC-TF-405, CSPL-108MHC-TF-400, CSPL-108MHC-TF-395, |
|                | CSPL-108MHC-TF-390  |

Form-ULID-003263 (DCS:12-LO-F0852) Issue: 19.1



#### **Summary of Test Results**

After the ammonia exposure test there is no evidence of major visual defects as described in IEC 61730-2:2004 Also including no mechanical deterioration or corrosion of module components.

After the ammonia exposure test the maximum power was not decreased by more than 5 % of the initial value. All the test results fulfil the requirements of standard: IEC 62716 edition 1.0, dated 2013-06. Photovoltaic (PV) modules – Ammonia corrosion testing.

| Test No. | Test Item   | Standard references,<br>clause                               | Result |
|----------|---|--|--------|
| 1        | Preconditioning   | IEC 61215 second edition, dated 2005-04.                     | Р      |
| 2        | Visual inspection   | IEC 61215 second edition, dated 2005-04, clause10.1.         | Р      |
| 3        | Maximum power determination                                     | IEC 61215:2005-04, Ed-2, 10.2                                | Р      |
| 4        | Dielectrics withstand test                                      | IEC 61215 second edition, dated 2005-04, clause 10.3         | Р      |
| 5        | Wet leakage current test  | IEC 61215 second edition,<br>dated 2005-04, clause<br>10.15. | Р      |
| 6        | Ground continuity test  | IEC61730-2 first edition, dated 2004-10, clause 10.4.        | Р      |
| 7        | Ammonia corrosion test  | IEC 62716 edition 1.0, dated 2013-06, clause 7.              | Р      |
| 8        | Visual inspection after Ammonia corrosion test                  | IEC 61215 second edition, dated 2005-04, clause10.1.         | Р      |
| 9        | Maximum power determination after Ammonia corrosion test        | IEC 61215:2005-04, Ed-2, 10.2                                | Р      |
| 10       | Dielectrics withstand test after Ammonia corrosion test         | IEC 61215 second edition, dated 2005-04, clause 10.3         | Р      |
| 11       | Wet leakage current test after<br>Ammonia corrosion test        | IEC 61215 second edition,<br>dated 2005-04, clause<br>10.15. | Р      |
| 12       | Ground continuity test after Ammonia corrosion test             | IEC61730-2 first edition, dated 2004-10, clause 10.4.        | Р      |
| 13       | Bypass diode functionality test after<br>Ammonia corrosion test | IEC 61701 edition 2.0,<br>dated 2011-12, clause 4.2          | Р      |

P: Meets the requirements F: Does not meet the requirement NA: Not applicable

Form-ULID-003263 (DCS:12-LO-F0852) Issue: 19.1



Abbreviations used in this report:

Pmax - Maximum power

Vmp - Maximum power voltage
Imp - Maximum power current
Isc - Short circuit current
Voc - Open circuit voltage

FF - Fill factor

N/A – not apply to the object

## **Master Equipment and Calibration details**

| Inst. ID No. | Instrument Type             | Test Number,<br>Test Title or<br>Conditioning | Range used      | Last Cal.<br>Date [YYYY-<br>MM-DD] | Next Cal. Date<br>[YYYY-MM-<br>DD] |
|--------------|-----------------------------|---|-----------------|------------------------------------|------------------------------------|
| CTTL-09517   | Solar simulator             | 3/9/13  | 1000W/m2        | 2024-02-18                         | 2025-02-17                         |
| CTTL-09579   | Light Meter                 | 2/8   | 200□20000<br>lx | 2024-03-12                         | 2025-03-11                         |
| CTTL-090□5   | Steel tape                  | 2/8   | 0□2500mm        | 2024-02-27                         | 2025-02-2□                         |
| CTTL-10325   | Reference PV<br>module      | 3/9/13  | 1               | 2023-08-14                         | 2024-08-13                         |
| CTTL-02□00   | Pyranometer                 | 1   | 1000W/m2        | 2023-12-20                         | 2024-12-19                         |
| CTTL-09093   | Outdoor test system         | 1   | 1000W/m2        | 2023-10-09                         | 2024-10-08                         |
| CTTL-07599   | Dielectrometer              | 4/5/10/11                                     | 0□□□V□<br>1000V | 2023-10-09                         | 2024-10-08                         |
| CTTL-07□00   | Withstand voltage<br>tester | 4/10  | 0□15□V□<br>10mV | 2023-10-09                         | 2024-10-08                         |
| CTTL-02□98   | Conductivity meter          | 5/11  | 0□9999Ωcm       | 2023-09-08                         | 2024-09-07                         |
| YD0004185    | Power supply                | □/12  | 100A/100V       | 2023-10-09                         | 2024-10-08                         |
| CTTL-09003   | Multimeter                  | □/12  | 500mV           | 2024-01-1                          | 2025-01-15                         |
| CTTL-02□11   | DC Clamp Meters             | □/12  | 100A            | 2023-07-20                         | 2024-07-19                         |

Form-ULID-003263 (DCS:12-LO-F0852) Issue: 19.1



| CTTL-09157 | Ammonia corrosion chamber         | 7      | 26~60℃; 70~98%  | 2024-02-29 | 2025-02-28 |
|------------|-----------------------------------|--------|-----------------|------------|------------|
| CTTL-09349 | Panel Gas<br>Flowmeter            | 7      | 0~10L/min       | 2023-07-13 | 2024-07-12 |
| CTTL-02728 | Stopwatch                         | 7      | 0~1800s         | 2023-07-10 | 2024-07-09 |
| CTTL-02728 | Stopwatch                         | 7      | 0~1800s         | 2024-07-08 | 2025-07-07 |
| CTTL-09578 | □n□rare□<br>thermometer           | 3/9/13 | -10~135℃        | 2024-03-14 | 2025-03-13 |
| CTTL-08577 | Temperature an□<br>humi□it□ meter | 1~13   | 0~30℃;<br>0~80% | 2023-09-13 | 2024-09-12 |

Remar□: □urin□ testin□ an□ measumeents no e□uipment out o calibration

| □ Test sample description   |             |     |                   |     |        |                  |                              |           |  |
|---|-------------|-----|-------------------|-----|--------|------------------|------------------------------|-----------|--|
| ampling rocedure  All the sample were selecte an prodice b client LLC donot select the sample size termine whether the sample size representation of the test sample size were we prodice with incomation relation to the cormulation of identication component materials used in the test sample size. |             |     |                   |     |        |                  |                              |           |  |
| □anu□acturer: 0ti□enSolar Pri□ate Limite□   |             |     |                   |     |        |                  |                              |           |  |
| Electrical Ratin ☐s:  |             |     |                   |     |        |                  |                              |           |  |
| oule oel  | □ <b>oc</b> | □sc | Pma□<br>□□□/Toler | □mp | □mp □A | □a□□<br>. s□stem | □a□□O□er -Current Protection | □imension |  |

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□dta□e □□

1500

 $\Box$ C $\Box$ 

Form-ULID-003263 (DCS:12-LO-F0852) Issue: 19.1

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ance

545

 $\Box C \Box$ 

49□16

CSPL-144□HC-

TF-545

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25A

 $\Box C \Box$ 



## 1.3. Sample identification:

| Sample card No. | Date Received [YYYY-MM-DD] | Sample<br>No. | Product Identification | Type/Model      |
|-----------------|----------------------------|---------------|------------------------|-----------------|
| 7153890         | 2024-05-29                 | 1             | Solar PV Module 585W   | CSPL-144MHC-TF- |
| Control         |                            | '             | SI No: CSPL24040033    | 545             |
| 7452004         | 2024-05-29                 | 2             | Solar PV Module 585W   | CSPL-144MHC-TF- |
| 7153891         |                            | 2             | SI No: CSPL24040034    | 545             |
| 7153892         | 2024-05-29                 | 3             | Solar PV Module 585W   | CSPL-144MHC-TF- |
|                 |                            | 3             | SI No: CSPL24040035    | 545             |

See the others sample information in appendix 1 and 2.

#### 2. Testing

Test program:

Overview of test items for test sample: The table below is provided to establish correlation of sample numbers to test numbers.

| Test No.     |   | Samples No. |   |
|--------------|---|-------------|---|
|              | 1 | 2           | 3 |
| Control      |   |             |   |
| 1 🗆 🗆 8 🗆 12 |   |             |   |
| 7            |   |             |   |
| 13           |   |             |   |

## 2.1. Preconditioning

Test procedure: Reference to □EC □1215 second edition □ dated 26004.

| Humidit□ □□R⊞                   | NⅢ   | □mbient □□C□           | N□□                             |  |  |
|---------------------------------|--|------------------------|---------------------------------|--|--|
| Tested b□                       | Fu□iang□äo                                   | Test □ate □□□□□-MM-□□□ | 2024-0□-18                      |  |  |
| Table 1: Preconditioning        |  |                        |                                 |  |  |
| Sample No.                      |  | 1□3                    |                                 |  |  |
| Load                            | Open circuit                                 |                        |                                 |  |  |
| Test □ate                       | □verage irradiance during exposed time□W□m□□ | Exposed time □h□       | □rradiation integation □□Wh□m□□ |  |  |
| 2024-0□-18                      | 855 5.8 5                                    |                        |                                 |  |  |
| Supplementar information: N □ □ |  |                        |                                 |  |  |

Form-ULID-003263 (DCS:12-LO-F0852) Issue: 19.1



## 2.2 Visual inspection

Test procedure: reference to IEC 61215 second edition, dated 2005-04, clause10.1.

| Humidity [%RH] | 45.8         | Ambient [°C]           | 25.1       |
|----------------|--------------|------------------------|------------|
| Tested by      | Fuqiang Jiao | Test Date [YYYY-MM-DD] | 2024-06-19 |

| Sample No. I   | Nature and position of initial findings – comments or attach photos | Critical [Yes or No] |
|----------------|---|----------------------|
| 1<br>(control) | No major finding N  | o                    |
| 2              | No major finding N  | 0                    |
| 3              | No major finding N  | 0                    |

Results: The samples-did not show any critical visual defect.

Form-ULID-003263 (DCS:12-LO-F0852) Issue: 19.1



## 2.2. Maximum power determination

Test procedure: reference to IEC 61215 second edition, dated 2005-04, clause 10.2.

| Humidity [%RH] | 46.1         | Ambient [°C]           | 25.1       |
|----------------|--------------|------------------------|------------|
| Tested by      | Fuqiang Jiao | Test Date [YYYY-MM-DD] | 2024-06-19 |

| Table 3: Maxir | num power d   | etermination | n [Initial] |           |         |             |           |                      |
|----------------|---------------|--------------|-------------|-----------|---------|-------------|-----------|----------------------|
| Light source   |               |              | [X]         | Simulator | []      | Natural sur | nlight    |                      |
| Sample No.     | Voc [V]       | Isc [A]      | Pmax [W]    | Vmp [V]   | Imp [A] | FF [%]      | Tmod [°C] | Irradiance<br>[W/m²] |
| 1-F(control)   | 50.176        | 13.252       | 533.589     | 42.674    | 12.504  | 80.25       | 25.0      | 1000.03              |
| 1-R(control)   | 49.601        | 9.961        | 388.832     | 42.839    | 9.077   | 78.70       | 25.1      | 1000.02              |
| 3-□(control)   | 50.303        | 14.518       | 583.686     | 42.792    | 13.640  | 79.93       | 25.1      | 1000.03              |
| 2-F            | 50.062        | 13.269       | 535.712     | 42.600    | 12.575  | 80.65       | 25.1      | 1000.03              |
| 2-R            | 49.505        | 9.897        | 387.370     | 42.759    | 9.059   | 79.06       | 25.0      | 1000.01              |
| 2-□            | 50.243        | 14.547       | 587.366     | 42.742    | 13.742  | 80.36       | 24.9      | 1000.02              |
| 3-F            | 50.121        | 13.254       | 534.385     | 42.630    | 12.535  | 80.45       | 25.1      | 1000.03              |
| 3-R            | 49.585        | 10.019       | 389.830     | 42.827    | 9.103   | 78.47       | 25.1      | 1000.02              |
| 3-□            | 50.291        | 14.511       | 585.550     | 42.780    | 13.687  | 80.24       | 24.9      | 1000.03              |
| Supplementar   | y information | : N/A        |             |           |         |             | 1         |                      |

Results: The IV cur □ e did not showany □ in □ or other unusual characteristic.

| Difference [%] compared to nameplate stated □alue |      |       |       |      |       |
|---|------|-------|-------|------|-------|
| Sample No.  | Voc  | Isc   | Pmax  | Vmp  | lmp   |
| 1-F<br>(control)                                  | 0.84 | -4.66 | -2.09 | 1.85 | -3.96 |
| 2-F   | 0.61 | -4.54 | -1.70 | 1.67 | -3.42 |

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| Difference [%] compared to nameplate stated value |        |        |        |     |       |
|---|--------|--------|--------|-----|-------|
| Sample No. V                                      | oc l   | sc P   | max    | Vmp | Imp   |
| 3-F   | 0.73 - | 4.65 - | 1.95 1 | .74 | -3.73 |

#### 3. Dielectrics withstand test

Test procedure: reference to IEC 61215 second edition, dated 2005-04, clause 10.3.

| Humidity [%RH] | 54.6         | Ambient [°C]           | 25.8       |
|----------------|--------------|------------------------|------------|
| Tested by      | Fuqiang Jiao | Test Date [YYYY-MM-DD] | 2024-06-20 |

| Table 4: Dielectr  | ic withstand test [Initia | al]  |  |   |                         |     |
|--|---------------------------|--|--|---|-------------------------|-----|
| Test voltage applied [V DC]  |                           | 1500 Test voltage applied [V   |  | [V DC]                                    | 8000                    |     |
| Sample No.   | Dielectric                | Module area [m²] $ \begin{array}{c} \text{Required} \\ \text{resistance [M$\Omega$]} \end{array} $ |  | Dielectric breakdown  Yes [description] N |                         | wn  |
| ·  | breakdown                 |  |  |   |                         | 0   |
| 1<br>(control)   | >10000                    |  |  | No diel                                   | ectric breakd           | own |
| 2  | >10000                    | 2.58 1 5.50 No (   |  |   | No dielectric breakdown |     |
| 3  | >10000                    |  |  | No diel                                   | ectric breakd           | own |
| Supplementary information: The maximum calibrated resistance measurement range is $10000M\Omega$ . |                           |  |  |   |                         |     |

Results: For modules with an area greater than 0.1 m<sup>2</sup>:

There was no indication of dielectric breakdown during the test.

There was no indication of surface tracking during the test.

The measured insulation resistance was/was not less than 15.50 megohms.

Form-ULID-003263 (DCS:12-LO-F0852) Issue: 19.1



## 3.1. Wet leakage current test

Test procedure: reference to IEC 61215 second edition, dated 2005-04, clause 10.15.

| Humidity [%RH] | 54.6         | Ambient [°C]           | 25.8       |
|----------------|--------------|------------------------|------------|
| Tested by      | Fuqiang Jiao | Test Date [YYYY-MM-DD] | 2024-06-20 |

| Table 5: Wet leakage current test [Initial] |                            |  |                                     |                          |  |
|---|----------------------------|--|-------------------------------------|--------------------------|--|
| Solution temperature [°                     | Solution temperature [°C]  |  | Solution resistivity [ $\Omega$ cm] | 2192                     |  |
| Test Voltage applied [V, dc] 1500           |                            |  |                                     |                          |  |
| Sample No.                                  | Measured resistance [MΩ] N |  | l odule area [m²]                   | Required resistance [MΩ] |  |
| 1<br>(control)                              | 1740                       |  | 0.50.4                              | 5.50                     |  |
| 2   | 2310                       |  | 2.58 1                              | 5.50                     |  |
| 3 1890                                      |                            |  |                                     |                          |  |
| Supplementary information: N/A              |                            |  |                                     |                          |  |

Results: For modules with an area greater than 0.1 m<sup>2</sup>, the measured insulation resistance was not less than 15.50 megohms.

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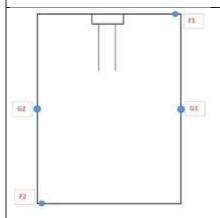
## 3.2. Ground continuity test

Test procedure: Reference to IEC61730-2 first edition, dated 2004-10, clause 10.4.

| Humidity [%RH] | 54.6           | Ambient [°C]          | 25.8       |
|----------------|----------------|-----------------------|------------|
| Tested by      | Fuqiang Jiao T | est Date [YYYY-MM-DD] | 2024-06-20 |

| Table 6: Ground continuity test            |      |
|--|------|
| Maximum over-current protection rating [A] | 25   |
| Current applied [A DC]                     | 62.5 |

Location of designated grounding point and accessible point on conductive components of the PV module



#### G1, G2: Designated point for equipotential bonding

## F1, F2: Conductive point of the PV module

| Sample No. | Test point | Voltage dropped [V DC] | Resistance [Ω] |
|------------|------------|------------------------|----------------|
| 1          | G1 to G2 0 | .374 0                 | .0060          |
| 2          | G1 to G2 0 | .336 0                 | .0054          |
| 3          | G1 to G2 0 | .389 0                 | .0062          |

Supplementary information: The resistance were calculated from the applied current and the resulting voltage drop measured at the connection points of the PV module [e.g. frame].

Results: The resistance between the selected exposed conductive component and other conductive components of the PV module was-less than  $0.1\Omega$ .

Form-ULID-003263 (DCS:12-LO-F0852) Issue: 19.1

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#### 3.3. Ammonia corrosion test

Test procedure: Reference to IEC 62716 edition 1.0, dated 2013-06, clause 7.

| Humidity [%RH] | 22.5~48.2      | Ambient [°C]          | 26.1~36.8             |
|----------------|----------------|-----------------------|-----------------------|
| Tested by      | Fuqiang Jiao T | est Date [YYYY-MM-DD] | 2024-06-21-2024-07-11 |

| Table 7: | Ammonia                        | corrosion test                 |                          |  |
|----------|--------------------------------|--------------------------------|--------------------------|--|
| Sample   | No.                            |                                | 2, 3                     |  |
|          |                                | Hours [h]                      | 8 (including heating up) |  |
|          | 1 test section  Cycles  2 test | NH₃-concentration [ppm]        | 6667                     |  |
|          |                                | Temperature [°C]               | 60±2                     |  |
| Cycles   |                                | Relative humidity [%RH]        | 98±2                     |  |
| Cycles   |                                | Hours [h]                      | 16 (including cooling)   |  |
|          |                                | NH <sub>3</sub> -concentration | 0                        |  |
|          | section                        | Temperature [°C]               | 26±2                     |  |
|          |                                | Relative humidity [%RH]        | 70±2                     |  |
| Duration | <u> </u><br>1                  | 20 cycles (480 h)              | l .                      |  |

Supplementary information: After measurement, the volume in the ammonia corrosion chamber is  $10.924 \, \text{m}^3$ , Set the gas flowmeter as  $8 \, \text{L}$  / min and inject ammonia for 9.1 minutes. After calculation, the NH3 concentration in the ammonia corrosion chamber is  $6667 \, \text{ppm}$ .

Form-ULID-003263 (DCS:12-LO-F0852) Issue: 19.1



## 3.4. Visual inspection after Ammonia corrosion test

Test procedure: reference to IEC 61215 second edition, dated 2005-04, clause10.1.

| Humidity [%RH] | 46.4         | Ambient [°C]           | 25.3       |
|----------------|--------------|------------------------|------------|
| Tested by      | Fuqiang Jiao | Test Date [YYYY-MM-DD] | 2024-07-12 |

|                | Nick and a siking of initial finalina                               | Critical    |
|----------------|---|-------------|
| Sample No.     | Nature and position of initial findings – comments or attach photos | [Yes or No] |
| 1<br>(control) | No major finding  | No          |
| 2              | No major finding  | No          |
| 3              | No major finding  | No          |

Results: The samples did not show any critical visual defect.

## 3.5. Maximum power determination after Ammonia corrosion test

Test procedure: reference to IEC 61215 second edition, dated 2005-04, clause 10.2.

| Humidity [%RH] | 46.9         | Ambient [°C]           | 25.1       |
|----------------|--------------|------------------------|------------|
| Tested by      | Fuqiang Jiao | Test Date [YYYY-MM-DD] | 2024-07-12 |

| Table 9: Ma⊡in | num powerd | eterminatior | n after Amm | onia corrosio | n test  |             |           |                      |
|----------------|------------|--------------|-------------|---------------|---------|-------------|-----------|----------------------|
| □ight source   |            |              |             | ] Simulator   | []      | Natural sun | llight    |                      |
| Sample No.     | Voc [V]    | Isc [A]      | □ma□ [□]    | Vmp [V]       | Imp [A] | FF [%]      | Tmod [°C] | Irradiance<br>[□/m□] |
| 1-F(control)   | 50.175     | 13.246       | 533.288     | 42.683        | 12.494  | 80.24       | 25.1      | 1000.04              |
| 1-R(control)   | 49.637     | 9.938        | 388.071     | 43.090        | 9.006   | 78.67       | 25.1      | 1000.01              |
| 3-□(control)   | 50.361     | 14.474       | 584.183     | 42.841        | 13.636  | 80.14       | 25.0      | 1000.02              |
| 2-F            | 50.168     | 13.191       | 533.926     | 42.686        | 12.508  | 80.68       | 25.1      | 1000.03              |

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Page 14 of 25



| 2-R | 49.613 9 | .859 3 | 85.983 4 | 3.065    | 8.963 | 78.91 | 25.0   | 1000.01 |
|-----|----------|--------|----------|----------|-------|-------|--------|---------|
| 2-B | 50.347 1 | 4.453  | 585.184  | 42.817 1 | 3.667 | 80.42 | 25.0   | 1000.04 |
| 3-F | 50.224 1 | 3.179  | 532.606  | 42.722 1 | 2.467 | 80.47 | 25.1 1 | 000.02  |
| 3-R | 49.677 9 | .970 3 | 86.371 4 | 3.126    | 8.959 | 78.01 | 25.0   | 1000.03 |
| 3-B | 50.392 1 | 4.429  | 583.818  | 42.865 1 | 3.620 | 80.29 | 25.0   | 1000.02 |

Supplementary information: N/A

## Results:

| Degradation [%]  | compared to initial t | est value |        |      |       |
|------------------|-----------------------|-----------|--------|------|-------|
| Sample No.       | Voc                   | Isc       | Pmax V | mp I | mp    |
| 1-F<br>(control) | 0.00 -                | 0.05 -    | 0.06 0 | .02  | -0.08 |
| 2-F              | 0.21 -                | 0.59 -    | 0.33 0 | .20  | -0.53 |
| 3-F              | 0.21 -                | 0.57 -    | 0.33 0 | .22  | -0.54 |

Results: The IV curve did not show any kink or other unusual characteristic.

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#### 3.6. Dielectric withstand test after Ammonia corrosion test

Test procedure: reference to IEC 61215 second edition, dated 2005-04, clause 10.3.

| Humidity [%RH] | 54.2         | Ambient [°C]           | 25.9       |
|----------------|--------------|------------------------|------------|
| Tested by      | Fuqiang Jiao | Test Date [YYYY-MM-DD] | 2024-07-15 |

| Test voltage applied [V DC] |                 | 1500                    | Test voltage applied | [V DC]                 | 8000          |      |
|-----------------------------|-----------------|-------------------------|----------------------|------------------------|---------------|------|
| Sample No.                  | Measured Mod    | Module area [m²]        | Required             |                        | ctric breakd  | own  |
| •                           | resistance [MΩ] | MΩ] resistance [ $MΩ$ ] | Yes [description] No |                        | No            |      |
| 1                           | >10000          |                         |                      | No die                 | lectric break | down |
| 2                           | >10000          | 2.58                    | 15.50                | No die                 | lectric break | down |
| 3                           | >10000          | _                       |                      | No dielectric breakdow |               | down |

| Test voltage applied [V DC] |                 | 1500             | Test voltage applied [V DC] |                         | 8000           |      |
|-----------------------------|-----------------|------------------|-----------------------------|-------------------------|----------------|------|
| Sample No. Measured         |                 | Module area [m²] | Required                    | Dielectric breakdown    |                | own  |
| ·                           | resistance [MΩ] |                  | resistance [MΩ]             | Yes [de                 | escription]    | No   |
| 1<br>□contro⊡               | □10000          |                  |                             | No die                  | electric break | down |
| 2                           | □10000          | 2.58             | 15.50                       | No dielectric breakdown |                |      |
| 3                           | □10000          | 1                |                             | No die                  | electric break | down |

Results: For modules with an area greater than 0.1 m<sup>2</sup>:

There was no indication of dielectric breakdown during the test.

There-was no indication of surface tracking during the test.

The measured insulation resistance was not less than 15.50 megohms.

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Page 16 of 25



## 3.7. Wet leakage current test Ammonia corrosion test

Test procedure: reference to IEC 61215 second edition, dated 2005-04, clause 10.15.

| Humidity [%RH] | 54.2           | Ambient [°C]          | 25.9       |
|----------------|----------------|-----------------------|------------|
| Tested by      | Fuqiang Jiao T | est Date [YYYY-MM-DD] | 2024-07-15 |

| Table 11: Wet leakage current test after Ammonia corrosion test |                            |                                |                             |                          |  |  |
|---|----------------------------|--------------------------------|-----------------------------|--------------------------|--|--|
| Solution temperature [°C]                                       |                            | 23.4                           | Solution resistivity [Ω cm] | 2347                     |  |  |
| Test Voltage applied [V, dc] 1500                               |                            | 1500                           |                             |                          |  |  |
| Sample No.  | Measured resistance [MΩ] M |                                | l odule area [m²]           | Required resistance [MΩ] |  |  |
| 1<br>(control)  | 2310                       |                                | 0.50.4                      | 5.50                     |  |  |
| 2   | 1690                       |                                | 2.58 1                      | 5.50                     |  |  |
| 3   | 1730                       |                                |                             |                          |  |  |
| Supplementary informa   | tion: N                    | Supplementary information: N/A |                             |                          |  |  |

Results: For modules with an area greater than 0.1 m², the measured insulation resistance was not less than 15.50 megohms.

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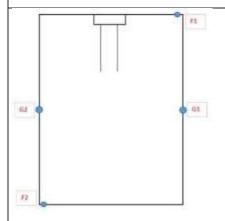
## 3.8. Ground continuity test after Ammonia corrosion test

Test procedure: Reference to IEC61730-2 first edition, dated 2004-10, clause 10.4.

| Humidity [%RH] | 54.2           | Ambient [°C]          | 25.9       |
|----------------|----------------|-----------------------|------------|
| Tested by      | Fuqiang Jiao T | est Date [YYYY-MM-DD] | 2024-07-15 |

| Table 6: Ground continuity test            |      |
|--|------|
| Maximum over-current protection rating [A] | 25   |
| Current applied [A DC]                     | 62.5 |

Location of designated grounding point and accessible point on conductive components of the PV module



## G1, G2: Designated point for equipotential bonding

#### F1, F2: Conductive point of the PV module

| Sample No. | Test point | Voltage dropped [V DC] | Resistance [Ω] |
|------------|------------|------------------------|----------------|
| 1          | G1 to G2 0 | .361 0                 | .0058          |
| 2          | G1 to G2 0 | .398 0                 | .0064          |
| 3          | G1 to G2 0 | .374 0                 | .0060          |

Supplementary information: The resistance were calculated from the applied current and the resulting voltage drop measured at the connection points of the PV module [e.g. frame].

Results: The resistance between the selected exposed conductive component and other conductive components of the PV module was less than  $0.1 \Omega$ .

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Page 18 of 25



## 3.9. Bypass diode functionality test after Ammonia corrosion test

Test procedure: Reference to IEC 61701 edition 2.0, dated 2011-12, clause 4.2

| Humidity [%RH] | 47.4           | Ambient [°C]          | 25.0       |
|----------------|----------------|-----------------------|------------|
| Tested by      | Fuqiang Jiao T | est Date [YYYY-MM-DD] | 2024-07-16 |

| Table 13: Bypas                               | ss diode function  | ality test after A | Ammonia | corrosio        | on test |  |       |
|---|--------------------|--------------------|---------|-----------------|---------|--|-------|
| Sample No. 2                                  |                    |                    | , 3     |                 |         |  |       |
| Number of diode                               | es in junction box | ( 3                |         |                 |         |  |       |
| STC short-circuit                             | it current [A]     |                    |         |                 |         | 13.90  |       |
| Current flow (1.2                             | 25 * Isc) [A]      |                    |         | 17.38           |         |  |       |
| Test duration (h                              | our) 1             |                    |         |                 |         |  |       |
| Diode functional                              | I2 Vee/Ne          |                    |         | Diode 1 Diode 2 |         | Diode 3  |       |
| Diode fullctional                             | r res/NO           |                    |         | ,               | Yes     | Yes  | Yes   |
| Diode function to                             | est (verify I-V cu | rve)               |         |                 |         |  |       |
| Sample No.2                                   |                    |                    |         |                 |         |  |       |
| Test Diode<br>No.                             | Voc [V]            | Isc [A] P          | ma      | x [W]           | Vmp [V] | Imp [A] F  | F [%] |
| 1   | 49.941 1           | 3.184              | 350     | .682            | 27.916  | 1 2.562  | 53.26 |
| 2   | 49.857 1           | 3.227              | 351     | .158            | 27.944  | 1 2.567  | 53.25 |
| 3   | 49.915 1           | 3.228              | 351     | .263            | 27.988  | 1 2.551  | 53.20 |
| I-V Curve for<br>cell shaded<br>under diode 1 |                    |                    | 1       | /<br>           |         | The second of th |       |

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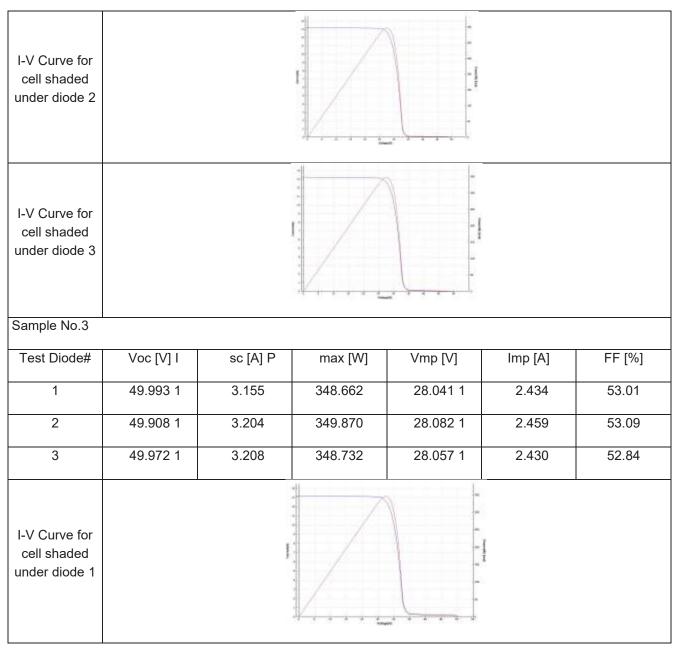
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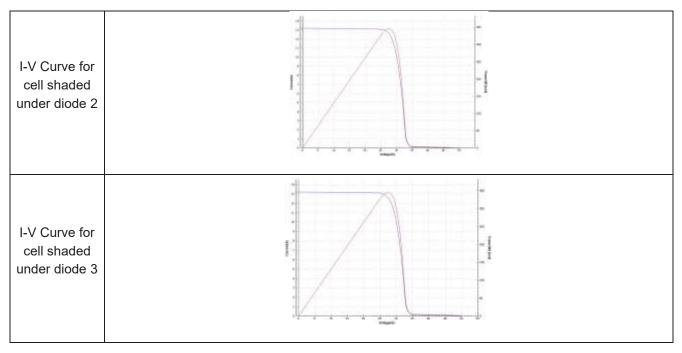
Page 19 of 25





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## Appendix1 - Product pictures



Module front view



Module rear view







Junction box

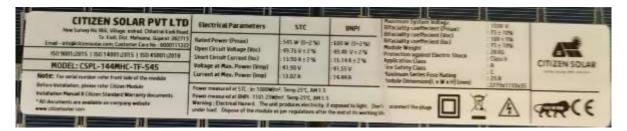
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Connectors

## Appendix2 – Product nameplate label



Model-CSPL-144MHC-TF-545

## Appendix3 - Statement of uncertainty

Expanded measurement uncertainty statement for Maximum power measurement:

| Isc    | Voc | Imp    | Vmp | Pmp  |
|--------|-----|--------|-----|------|
| 2.3% 1 | .0% | 2.3% 1 | .0% | 2.4% |

The expanded measurement uncertainty resulting from the standard measurement uncertainty multiplied with a factor k=2 is specified, denoting the deviations of the measurement value within a probability of 95%.

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Page 23 of 25



## Appendix 5

## Bill of Material As declared by customer.

| Module Model:                  | CSPL-144MHC-TF-545  |
|--------------------------------|---|
| Front Cover:                   | High transmission low iron tampered AR coated glass, Thickness 3.2  |
|                                | mm, Textured, High Transmission (>94% for ARC),   |
|                                | Manufacturer By: Borosil Renewables Ltd. India  |
| Rear Cover                     | Manufacturer By: Renewsys India Pvt Ltd, Bangalore<br>Model: PRESERV-1-300WD (For White) Total Thickness: 395 μm<br>Model: PRESERV-1-300 TF (For Transparent) Total Thickness: 360 μm<br>Model: PRESERV – 1 300 K2D (for black) Total Thickness: 360 μm |
| Encapsulation material:        | Manufacturer By: Renewsys India Pvt Ltd, Bangalore  |
|                                | Model No: Conserve P UVT 14FC (Front) 600GSM & Conserve P 360-14FC (Back) 550GSM  |
| Frame:                         | Anodized Aluminium Alloy- 6063 -T6, 15 - 20 micron.  Manufacturer By: Vinitech Metal Private Limited  |
| Dimensions (I x w x h) [mm].:  | 2279mm x1133 mm x35 mm  |
| Module area [m²]: 2            | .58 [m²]  |
| PV Cell: M                     | anufacturer By: United Renewable Energy Co. Ltd<br>Mono-crystalline PERC Bifacial Solar half cut cell- M10, cell size /Format:<br>182 mm x 182 mm ± 0.5 mm, Thickness: 175 µm±17.5 µm   |
| Cell- and string connectors: M | anufacturer By: Shanghai Sunby Solar Technology Co Ltd, China<br>Tin coated copper wire Top & bottom 0.35*4mm, JB connector<br>0.35*6mm.  |
| Junction box:                  | Manufacturer By: DhaSh PV Technologies Private Limited Bangalore. Model: DSJB12Y Type: Split Type Rated voltage: 1500 VDC, IP68, Class II, Application Class A, PD1, Flammability class: UL-94 V0, 5VA  |
| Adhesive for frame:            | Manufacturer By: Shanghai Huitian New Material Co Ltd<br>Silicone s ealant M odel-HT906Z IN H AI = 0, H WI = 3 , Flame class<br>HB75(WT)  |
| Adhesive for junction box: M   | anufacturer By: Shanghai Huitian New Material Co Ltd<br>Silicone s ealant M odel-HT906Z IN H AI = 0, H WI = 3, Flame class<br>HB75(WT)  |
| Tape M                         | odel 7946, Manufacturer By: TESA TAPES INDIA PVT.LTD  |
| Bypass diode:                  | Diode Type/ Number MK5045,<br>Standard: IEC 62790:2020, 25A Max rated current<br>Manufacturer By: Taizhou Chuangda Electronics Co. Ltd  |

\*\*\*\*\*\*End of Report\*\*\*\*\*

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Page 24 of 25

Report Number:



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